Search Notes				
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/661,543	SAIGO ET AL.
Examiner	Art Unit
Richard H Kim	2871

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
No additional Search	7/6/06	RK	